

<b>Notice of References Cited</b>	Application/Control No. 10/002,745	Applicant(s)/Patent Under Reexamination UENO, TOSHIO	
	Examiner Philip J. Chea	Art Unit 2153	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5,446,883 A	08-1995	Kirkbride et al.	707/10
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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